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(Title Amended 3/83)

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Applicant

Thomas James Batzinger et al.

Filing Date

September 12, 2003

Group

2858

INFORMATION DISCLOSURE STATEMENT BY APPLICANT--

LIST OF ITEMS

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
BC	AA	3	8	7	6	9	3	2	04/08/75	Domon et al.	—	—
1	AB	5	4	3	0	3	7	6	07/04/95	Viertl	—	—
	AC											
	AD											
	AE											
	AF											
	AG											
	AH											
	AI											
	AJ											
	AK											

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION		
		AL	2	1	0	9	1	1	2	A	05/25/83	GB	—	—	Yes
BC	AM	0	5	1	8	6	3	5	A	12/16/92	EP	—	—	—	—
	AN														
	AO														
	AP														

OTHER INFORMATION (Including Author, Title, Date, Pertinent pages. Etc.)

BC	AR	Patent Abstract of Japan, 2003240762A, H. Tatsuo, "Probe for Eddy Current Flaw Detection and Eddy Current Flaw Detecting Apparatus Using The Same", Vol. 2003, No. 12, August 27, 2003.
BC	AS	European Search Report, EP04255457, D. Joyce, November 12, 2004.
	AT	

EXAMINER

DATE CONSIDERED

2/24/05

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to applicant.